Issue Classification

CLASS

362

12 13 13 15 16 14 /LEAH S LOVELL/ Examiner.Art Unit 2885

(Assistant Examiner)

/Jong-Suk (James) Lee/

ORIGINAL

CROSS REFERENCE(S)

622

Application/Control No.

10564294

Examiner

SUBCLASS

LEAH S LOVELL

Applicant(s)/Patent Under Reexamination

NON-CLAIMED

Total Claims Allowed:

20

O.G. Print Figure

O.G. Print Claim(s)

DE VAAN, ADRIANUS JOHANNES STEPHANES

Art Unit

7 / 22 (2006.01.01)

INTERNATIONAL CLASSIFICATION

2885

CLAIMED

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3.2 (Primary Examiner) (Date) U.S. Patent and Trademark Office Part of Paper No. 20081106

6 Nov '08

(Date)

11/6/08

Issue Classification



LEAH S LOVELL

Application/Control No.

Applicant(s)/Patent Under Reexamination

DE VAAN, ADRIANUS JOHANNES
STEPHANES

Examiner

Art Unit

2885

/LEAH S LOVELL/ Examiner.Art Unit 2885	6 Nov '08	Total Claims Allowed:			
(Assistant Examiner)	(Date)	20			
/Jong-Suk (James) Lee/	11/6/08	O.G. Print Claim(s)	O.G. Print Figure		
(Primary Examiner)	(Date)	1	3,2		

U.S. Patent and Trademark Office Part of Paper No. 20081106